


<b>Search Notes</b>  	<b>Application/Control No.</b>  10563254	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  NATHAN H EMPIE	<b>Art Unit</b>  1792

SEARCHED			
Class	Subclass	Date	Examiner
427	376.1	12/108/	NHE

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search	12/1/08	NHE
EAST search report included	12/1-2/08	NHE
Internet search using similar keywords as in EAST search	12/1-2/08	NHE
Discussed prior art Yokogawa with Steven Spar (Japanese translator)	12/1/08	NHE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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